# High-Resolution Angular Displacement Technology Based on Varying Moiré Figure Phase Positions 

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#### Abstract

Angular displacement measurement is a popular research subject. The grating of traditional angular measurement devices uses multi-circle code and is difficult to miniaturize. This paper proposes a novel angular displacement technology based on varying moiré figure phase positions which allows for reduced volume and high-resolution angle measurements in small-size gratings. First, a moiré figure phase model is established and the calculation arithmetic is written. Second, the proposed arithmetic based on differences in moiré figure phase positions is completed accordingly. At last, a test device was fabricated based on the proposed theory with a total diameter of 35 mm and grating diameter of $\mathbf{2 5} \mathbf{~ m m}$. These tests show that angular displacement method based on differences of moiré figure phase positions can achieve a high resolution measurement when the diameter of calibration grating is small. We hope the results of this paper provide a workable theoretical foundation for future photographic encoders.


Index Terms-Angular measurement, moiré figure, phase difference, high resolution.

## I. Introduction

HIGH-RESOLUTION and high-precision angle measurement techniques are a popular research subject [1]-[3]. It is widely used in many fields, such as radar, aerospace, robot, CNC machine tool and high precision closed-loop speed control system, because of its high precision, high resolution, wide measurement range, easy maintenance and reliable use. In aerospace, military and industrial fields, which have strict requirements on the volume and weight of devices, the requirements of photoelectric encoder not only reduce the size and weight, but also improve the resolution and precision of photoelectric encoder. At present, it is a hot research topic to improve the resolution and angle measurement accuracy of photoelectric encoder while reducing the code disk.

Development trends currently favor image detection [4]-[11] instead of traditional photoelectric conversion elements and imaging processes as opposed to

[^0]moiré figures when grating size is small [12]-[15]. These techniques realize high measurement resolution, but their dynamic performance may be degraded by the frequency response of the image detector [14], [16], [17]. Moiré figures may, however, function properly under stringent frequency response and small grating size conditions while providing high-resolution measurements [18], [15].

There is a wealth of research on photoelectric encoders. The absolute encoder designed by Heidenhain Company, which has a large circular grating, can reach 27-bit resolution [19]; a likewise large and ultra-high resolution absolute encoder was designed by the Goddard Space Center as an optical pattern recognition and image processing technology. These devices measure their targets via grating calibration, where the grating is used to draw a moiré figure from which the photo electricity signal is collected by photoelectric conversion. Codes must be supplied to the grating, e.g., natural binary code, gray code, matrix code. Several circular lines are carved on the grating to ensure high measurement resolution. When the grating is small in size, however, it is very difficult to achieve high resolution.

This paper proposes a novel absolute angle measurement method which works based on differences in moiré figure phase positions. We built a moiré figure model and phase arithmetic, then developed a new angle measurement model based on varying moiré figure phase positions. We designed a $\Phi 35-\mathrm{mm}$ diameter encoder to test the proposed method and achieved resolution up to $0.62^{\prime \prime}$ with mean-square error deviation of $21.14^{\prime \prime}$. The proposed setup represents significant advantages, to this effect, over the traditional encoder.

The remainder of this paper is organized as follows: Section 2 discusses the moiré figure model. Section 3 discusses the proposed high-resolution angular displacement technology based on varying moiré figure phase positions. Section 4 presents our designed device. Section 5 explains the errors analyses. Section 6 reports our test results. Section 7 provides a brief summary and conclusion.

## II. Principle of Moiré Fringes

## A. Moiré Figure Model

Moiré fringe is a commonly used measurement signal. Moiré fringes can be generated by two relatively moving gratings, as shown in Figure 1.

In Figure 1, the angle between the calibrated grating and the indicating grating is $\alpha$. When the calibration grating and the indicator grating are relative moving, the light passing through the grating pair forms a sinusoidal-like series of variations.


Fig. 1. Moiré fringe principle.


Fig. 2. Moiré figure conversion principle.

When the angle $\alpha$ is small, the relative displacement is $z$ and the grating period is $d$. Under the illumination of the unit light, the light intensity passing through the indicator grating can be expressed as follows:

$$
\begin{equation*}
I=\sin \left(2 \pi \cdot \frac{\mathrm{Z}}{d}+\varphi_{0}\right) \tag{1}
\end{equation*}
$$

where $\varphi_{0}$ is the initial phase; $2 \pi$ is the sine function period; $\varphi_{0}$ has different values at different locations in the indicator grating. The displacement $z$ can be determined by measuring the sine function phase in Formula (1).

## B. Phase Arithmetic

To measure the angular displacement, we installed the calibrated grating on the axis of rotation, fixed the indicator grating, and converted the moiré fringes into electrical signals by using the photosensitive elements shown in Figure 2.

The indicator grating phase shift produced $\varphi_{0}=0$, $\varphi_{0}=\pi / 2, \varphi_{0}=\pi$, and $\varphi_{0}=3 \pi / 2$ (four channel) moiré fringe. They can be changed to electrical signals via the photoelectric conversion elements as shown in Formula (2).

$$
\left\{\begin{array}{l}
P_{1}=A \sin (\omega)  \tag{2}\\
P_{2}=A \sin (\omega+\pi / 2) \\
P_{3}=A \sin (\omega+\pi) \\
P_{4}=A \sin (\omega+3 \pi / 2)
\end{array}\right.
$$



Fig. 3. Phase model in polar coordinates.
where $A$ is the moiré signal amplitude; $\omega$ is the phase. The value of $\omega$ contains the angular displacement.

We first need to calculate the phase of Moiré fringe to achieve angular displacement measurement. The following two trigonometric functions eliminate the sensitivity to nonlinearities:

$$
\left\{\begin{array}{l}
x=P_{1}-P_{3}=2 A \sin (\omega)  \tag{3}\\
y=P_{2}-P_{4}=2 A \cos (\omega)
\end{array}\right.
$$

where $x, y$ are two electrical signals with the phase difference $\pi / 2$ period. According to Formula (3), the phase can be calculated as follows:

$$
\begin{equation*}
\omega=\operatorname{atan}(x / y) \tag{4}
\end{equation*}
$$

The results of Formula (4) are in the range of $-\pi / 2 \sim \pi / 2$, so the model of Formula (4) is wrapped.

We drew two moiré signals in polar coordinates as shown in Figure 3.

The included angle $\omega$ is the phase angle of two signals. We divided an area every $\pi / 4$ angle in one circle to create eight areas in total. The corresponding phase "unwrapping" arithmetic is as follows.

In area $1,0 \leq \omega<\pi / 4, \omega=\operatorname{atan}(x / y)$;
In area $2, \pi / 4 \leq \omega<\pi / 2, \omega=\pi / 2-\operatorname{atan}(x / y)$;
In area $3, \pi / 2 \leq \omega<3 \pi / 4, \omega=\pi / 2+\operatorname{atan}(-x / y)$;
In area $4,3 \pi / 4 \leq \omega<\pi, \omega=\pi-\operatorname{atan}(y /-x)$;
In area $5, \pi \leq \omega<5 \pi / 4, \omega=\pi+\operatorname{atan}(-y /-x)$;
In area $6,5 \pi / 4 \leq \omega<3 \pi / 2, \omega=3 \pi / 2-\operatorname{atan}(-x /-y)$;
In area $7,3 \pi / 2 \leq \omega<7 \pi / 4, \omega=3 \pi / 2+\operatorname{atan}(x /-y)$;
In area $8,7 \pi / 4 \leq \omega<2 \pi, \omega=2 \pi-\operatorname{atan}(-y / x)$.
Which yields the "unwrapping" phase-values $\omega$.

## III. Principle of Varying Moire Fiprinciple of Moiré Fringe Phase Positions

## A. Varying Moiré Figure Phase Model

Rotating the grating around produces an abundance of periodic moiré fringe signals. The absolute angular position information cannot be obtained by focusing on solely one channel phase fringe signal.

For absolute angle measurement, we marked three circles of grating lines on the calibrated grating. The three channels are $\mathrm{S} 1, \mathrm{~S} 2$, and S 3 . S 1 has $2^{\mathrm{n}}$ grate lines, S 2 has $2^{\mathrm{n}}-1$ grate


Fig. 4. Grating pattern.
lines, and S 3 has $2^{\mathrm{n}}-2^{\mathrm{m}}$ grate lines. The grating pattern is shown in Figure 4. There are four lines for each circle in the indicator grating which provide four signals $\left(\mathrm{P}_{1} \sim \mathrm{P}_{4}\right)$ of each channel moiré fringe, such as Formula (4).

The grating periods of $\mathrm{S} 1, \mathrm{~S} 2$, and S 3 are $d_{1}=360 / 2^{\mathrm{n}}$, $d_{2}=360 /\left(2^{\mathrm{n}}-1\right)$, and $d_{3}=360 /\left(2^{\mathrm{n}}-2^{\mathrm{m}}\right)$. When the measured angle displacement is $\theta$, it can be plugged into Formula (2) and Formula (3) to determine the moiré fringe electrical signals of $\mathrm{S} 1, \mathrm{~S} 2$, and S 3 as $\left(\mathrm{x}_{1}, \mathrm{y}_{1}\right),\left(\mathrm{x}_{2}, \mathrm{y}_{2}\right)$, and ( $\mathrm{x}_{3}, \mathrm{y}_{4}$ ).

The moiré fringe signals for circle S 1 are determined as follows:

$$
\left\{\begin{array}{l}
x_{1}=A \sin \left(\omega_{1}\right)=A \sin \left(2 \pi \cdot \frac{\theta}{360 / 2^{n}}\right)  \tag{5}\\
y_{1}=A \cos \left(\omega_{1}\right)=A \sin \left(2 \pi \cdot \frac{\theta}{360 / 2^{n}}+\pi / 2\right)
\end{array}\right.
$$

For the S 2 circle, the moiré fringe signals are as follows:

$$
\left\{\begin{array}{l}
x_{2}=A \sin \left(\omega_{2}\right)=A \sin \left[2 \pi \cdot \frac{\theta}{360 /\left(2^{n}-1\right)}\right]  \tag{6}\\
y_{2}=A \cos \left(\omega_{2}\right)=A \sin \left[2 \pi \cdot \frac{\theta}{360 /\left(2^{n}-1\right)}+\pi / 2\right]
\end{array}\right.
$$

and for the S3 circle:

$$
\left\{\begin{array}{l}
x_{3}=A \sin \left(\omega_{3}\right)=A \sin \left[2 \pi \cdot \frac{\theta}{360 /\left(2^{n}-2^{m}\right)}\right]  \tag{7}\\
y_{3}=A \cos \left(\omega_{3}\right)=A \sin \left[2 \pi \cdot \frac{\theta}{360 /\left(2^{n}-2^{m}\right)}+\pi / 2\right]
\end{array}\right.
$$

where $\omega_{1}, \omega_{2}, \omega_{3}$ are phases of the three channel moiré fringe signals, respectively; $\theta$ is current angle displacement; 360 is the angle of one circle.

The phase $\omega_{1}, \omega_{2}, \omega_{3}$ can be calculated as follows:

$$
\begin{align*}
& \omega_{1}=2 \pi \cdot 2^{n} \cdot \frac{\theta}{360}=\operatorname{actan}\left(\frac{x_{1}}{y_{1}}\right)  \tag{8}\\
& \omega_{2}=2 \pi \cdot\left(2^{n}-1\right) \cdot \frac{\theta}{360}=\operatorname{actan}\left(\frac{x_{2}}{y_{2}}\right)  \tag{9}\\
& \omega_{3}=2 \pi \cdot\left(2^{n}-2^{m}\right) \cdot \frac{\theta}{360}=\operatorname{actan}\left(\frac{x_{3}}{y_{3}}\right) \tag{10}
\end{align*}
$$

The absolute angular position information can be calculated from the differences of $\omega_{1}, \omega_{2}, \omega_{3}$. So, the difference in $\omega_{1}$ and $\omega_{2}$ are normalized:

$$
\begin{equation*}
\Delta_{1}(\theta)=\frac{\omega_{1}-\omega_{2}}{2 \pi}=\frac{\theta}{360} \tag{11}
\end{equation*}
$$



Fig. 5. Curves of $\Delta_{1}(\theta)$ and $\Delta_{2}(\theta)$.


Fig. 6. Data combination.
as is the difference in $\omega_{1}$ and $\omega_{3}$ :

$$
\begin{equation*}
\Delta_{2}(\theta)=\frac{\omega_{1}-\omega_{3}}{2 \pi}=\frac{\theta}{360 / 2^{m}}-k, \quad k=0,1, \ldots, 2^{m}-1 \tag{12}
\end{equation*}
$$

where $k$ is the periodic number of $\Delta_{2}(\theta)$.
From Formula (11) and Formula (12), $\Delta_{1}(\theta)$ is directly proportional to $\theta$ and the period of $\Delta_{1}(\theta)$ is one circle. The period of $\Delta_{2}(\theta)$ is $360 / 2^{\mathrm{m}}$, as shown in Figure 5. The period of $\Delta_{2}(\theta)$ is $2^{\mathrm{m}}$ times that of $\Delta_{1}(\theta)$.
By $\Delta_{1}(\theta)$, the absolute angular measurement is complete. In practice, however, the results of $\omega_{1}$ and $\omega_{2}$ are affected by many factors. The value of $\Delta_{1}(\theta)$ contains a certain error jitter, so the resolution of $\Delta_{1}(\theta)$ is inherently low. Here, we use $\Delta_{2}(\theta)$ as the low-bit part of the angle values to enhance the measurement resolution.

## B. Arithmetic of Data Linkage

Formulas (11) and (12) indicate that the frequency of $\Delta_{1}(\theta)$ and $\Delta_{2}(\theta)$ are 1 and $2^{m}$ in one circle. According to this periodic relationship, after $\Delta_{2}(\theta)$ changes by one circle, $\Delta_{1}(\theta)$ changes one bit. Similarly, when $\omega_{1}$ changes by one circle, $\Delta_{2}(\theta)$ changes one bit. We linked the data accordingly as shown in Figure 6.
For binary calculation, we multiplied $\Delta_{1}(\theta)$ by $2^{\mathrm{m}}$ and $\Delta_{2}(\theta)$ by $2^{\mathrm{n}-\mathrm{m}}$ as follows:

$$
\begin{align*}
& B_{1}=2^{m} \cdot \Delta_{1}(\theta)  \tag{13}\\
& B_{2}=2^{n-m} \cdot \Delta_{2}(\theta) \tag{14}
\end{align*}
$$



Fig. 7. Test device.


Fig. 8. Principle of designed device. (1) spindle, (2) flange, (3) parallel light, (4) calibration grating, (5) indicator grating, (6) photoelectric conversion array, and (7) circuit.

Then to increase the resolution, we placed $\omega_{1}$ in the last portion of the data and multiplied $\omega_{1}$ by $2^{\mathrm{N}}$ :

$$
\begin{equation*}
B_{3}=2^{N} \cdot \frac{\omega_{1}}{2 \pi} \tag{15}
\end{equation*}
$$

We then obtained quantified data by $\mathrm{B} 1, \mathrm{~B} 2$, and B 3 . B 1 is a high $m$-bit, B 2 is a middle ( $\mathrm{n}-\mathrm{m}$ )-bit, and B3 is a low N -bit. The measured angle value $\theta$ can be written in binary form as follows:

$$
\begin{equation*}
\theta_{\mathrm{bin}}=B_{1} \cdot 2^{n-m+N}+B_{2} \cdot 2^{N}+B_{3} \tag{16}
\end{equation*}
$$

The resolution is $m+(n-m)+N=n+N$ bits.

## IV. Angle Measurement Device Design

We designed a test device as shown in Figure 7. It has overall diameter of 35 mm , length of 40 mm , and grating diameter of 25 mm .

The principle of designed device is shown in Figure 8. The figure includes: (1) spindle, (2) flange, (3) parallel light, (4) calibration grating, (5) indicator grating, (6) photoelectric conversion array, and (7) circuit components. The parallel light through the calibration grating and the indicator grating generates three-channel Moiré fringe signals. The photoelectric conversion array then converts the three Moiré fringes into electrical signals. In the circuit, the A/D conversions convert the three-channel signals to digital signals, respectively, and calculate the absolute angle value $\theta$.

## A. Light Design

To ensure the purity of the Moiré fringe signal, we used an optical lens to converge the light source and thus form a


Fig. 9. Parallel light source.


Fig. 10. Grating pattern.


Fig. 11. Calibration grating adjustment.
parallel light source (Figure 9). The point light source is a 460 nm LED and the lens focal length is 5 mm .

## B. Calibration Grating Design

We designed three codes on our grating. According to Section 3.1, we let the cycles of $S 1, S 2$, and $S 3$ be $2^{\mathrm{n}}=2^{10}$, $2^{\mathrm{n}}-1=2^{10}-1$, and $2^{\mathrm{n}}-2^{\mathrm{m}}=2^{10}-2^{5}$. The diameter of designed grating is 25 cm as shown in Figure 10 with "Zero" as shown in the magnified inset. We designed the pattern by using CAD software, and the photocopy the pattern to glass. The error of marking position is less than $0.01 \mu \mathrm{~m}$.

## C. Calibration Grating Adjustment

The installation of the calibration grating directly affects the accuracy of the angular displacement measurement. When designing the designed device, we used a microscope to observe the grate lines on the grating. The process is shown in Figure 11.

We observed grate line images via the microscope which allowed us to ensure all the grate lines have the same radius. Through debugging, when the grating is rotated for one circle, all the grate line radii have errors below $4 \mu \mathrm{~m}$.

The indicator grating was installed very near to the calibration grating to reduce the influence of light diffraction. The parallel light source was designed to illuminate the grating pairs immediately upon start-up.

## D. Device Resolution

In our design, $m=5$-bit and $n=10$-bit. In the quantification of $\omega_{1}$, we quantified $2^{8}$ data in every area shown in Figure 2. There are $8=2^{3}$ areas altogether, so we achieved $2^{\mathrm{N}}=2^{8+3}=2^{11}$ quantification of $\omega_{1}$. According to Formula (16), the resolution of our designed device is $(\mathrm{n}+\mathrm{N}=10+11)$ 21-bit.

## E. Response Frequency

Maximum response frequency is an important parameter of angle measurement. In our designed device, there are 3(moiré fringe channel) $\times 2$ (signals) A/D conversions. Each A/D cost $10 \mu$ s to complete a single conversion. The angle calculation arithmetic costs $200 \mu \mathrm{~s}$, so the maximum response frequency of designed device is $1 /(6 \times 10 \mu \mathrm{~s}+200 \mu \mathrm{~s})=3.85 \mathrm{kHz}$. This frequency is high enough for most practical applications, but could be increased by installing high performance electronic components.

## V. Errors Analysis

According to previous studies, the error of angular displacement mainly includes long period errors and short period errors [20].

## A. Long-Period Errors

The long period error is mainly caused by the eccentricity of the grating. Set the radius of the grating used be $r$, the distance between the center of the circle and the center of rotation be $e$, and the angle between the deviation direction and the zero position measured by the angle be $\Delta \theta$. The error caused by the eccentricity of the grating can be expressed as

$$
\begin{equation*}
\mu_{1}=\arctan \left(\frac{e \cdot \sin \Delta \theta}{r-e \cdot \sin \Delta \theta}\right) \cdot \frac{180^{\circ}}{\pi} \tag{17}
\end{equation*}
$$

It can be seen that when the larger grating is used, the error caused by eccentricity can be effectively reduced.

## B. Short-Period Errors

The short period error is mainly caused by the deviation of the amplitude and phase of the electric signals such as Moiré fringe. The short period error is composed of multiple harmonic components, which can be expressed as

$$
\begin{align*}
\mu_{2}=U_{1} & \sin \left(\omega+\beta_{1}\right)+U_{2} \\
& \times \sin \left(2 \omega+\beta_{2}\right)+U_{3} \sin \left(3 \omega+\beta_{3}\right)+\ldots \tag{18}
\end{align*}
$$

In the formula (18), $\omega$ is the angle values, $U_{1}, U_{2}$ and $U_{3}$ are the amplitudes of each harmonic, $\beta_{1}, \beta_{2}, \beta_{3}$ are the phase of each harmonic.

In order to eliminate the error in Eq. (18), we adjust the amplitude and phase of the Moiré fringe signal to an approximate ideal condition.


Fig. 12. The results of signal test.


Fig. 13. Differentials of output data.

## VI. EXPERIMENTS

## A. Signal Test

We collect signals of $x_{1}$ and $y_{1}$ as shown in figure 12(a) and figure 12(b). The phase difference is $\pi / 4$, so the Lissajous in figure12(a) is roundness. By metering, the range of noise in signal is 24 mV , the range of signal is 3 V , so the signal noise ratio is $10 \log (16 / 0.024)=20.97 \mathrm{~dB}$. This value is suited for angle measurement.

The Lissajous between $x_{1}$ and $x_{2}$ is shown in figure 12(c) and Lissajous between $x_{1}$ and $x_{3}$ is shown in figure 12(d). After one circular rotation of the axis, the phase difference between $x_{1}$ and $x_{2}$ has changed from 0 to $2 \pi$ for one period, the phase difference between $x_{1}$ and $x_{3}$ has changed from 0 to $2 \pi$ for one period.

These results in figure 12 fit the principle in section III.

## B. Resolution Test

We revolved the designed device with a servo motor at a uniform and slow speed and calculated the differentials of the output data (Figure 13). All differential data was steady when the device rotated at a uniform speed, which indicates that all the 21-bits are exact. In effect, the proposed device exhibited higher resolution than traditional small-size encoders (not higher than 18-bit).


Fig. 14. Principle precision test.

TABLE I
Error Detection

| Angle position | Errors | Angle position | Errors |
| :---: | :---: | :---: | :---: |
| $0^{\circ}$ | $0^{\prime \prime}$ | $195^{\circ}$ | $-32.5^{\prime \prime}$ |
| $15^{\circ}$ | $6^{\prime \prime}$ | $210^{\circ}$ | $-42.5^{\prime \prime}$ |
| $30^{\circ}$ | $10.5^{\prime \prime}$ | $225^{\circ}$ | $-46.5^{\prime \prime}$ |
| $45^{\circ}$ | $14^{\prime \prime}$ | $240^{\circ}$ | $-43.5^{\prime \prime}$ |
| $60^{\circ}$ | $13.5^{\prime \prime}$ | $255^{\circ}$ | $-39.5^{\prime \prime}$ |
| $75^{\circ}$ | $14^{\prime \prime}$ | $270^{\circ}$ | $-31.5^{\prime \prime}$ |
| $90^{\circ}$ | $14^{\prime \prime}$ | $285^{\circ}$ | $-26^{\prime \prime}$ |
| $105^{\circ}$ | $7.5^{\prime \prime}$ | $300^{\circ}$ | $-18^{\prime \prime}$ |
| $120^{\circ}$ | $3^{\prime \prime}$ | $315^{\circ}$ | $-11^{\prime \prime}$ |
| $135^{\circ}$ | $-3 \prime \prime$ | $330^{\circ}$ | $-2^{\prime \prime}$ |
| $150^{\circ}$ | $-13.5^{\prime \prime}$ | $345^{\circ}$ | $-1^{\prime \prime}$ |
| $165^{\circ}$ | $-18.5^{\prime \prime}$ | $360^{\circ}$ | $0 \prime$ |
| $180^{\circ}$ | $-23 \prime \prime$ |  |  |



Fig. 15. Three-time tests.

## C. Precision Test

We measured the proposed device by an angle-reference with precision of $2^{\prime \prime}$ and resolution of $0.07^{\prime \prime}$. We recorded the output data of both the designed device and angle-reference at each $15^{\circ}$ point. The error was calculated according to differences values between the two devices as shown in Figure 14 and Table 1.

As shown in Table 1, we obtained a mean-square error deviation of $21.14^{\prime \prime}$. We ran three separate detection experiments as shown in Figure 15. The maximum error was 15" and minimum error was $-45^{\prime \prime}$. These results indicate that the proposed device has excellent precision.

## D. Error Analysis

According to Section V, we analyze the errors in figure 15 as follow:

The short-period errors are very small. It explains that the Moiré figure is approximate ideal condition.

Meanwhile, we can find long-period errors obviously which looks like a sine curve. According to formulate (17), we can calculate the eccentricity value is about $e=3.3 \mu \mathrm{~m}$.

## E. Uncertainty Test

In precision test, the main factors affecting the calibration results include quantization error $\delta_{1}$, coaxial connection error $\delta_{2}$ and angle reference error $\delta_{3}$.

Quantization error is caused by the resolution of the device under test. The resolution of the angular measuring device designed by us is $0.62^{\prime \prime}$, so $\delta_{1}=0.62^{\prime \prime}$.
The coaxial connection error is mainly caused by the different axes when the measured device is connected with the angle reference through the coupling. When we calibrate, we use micrometer to measure coaxial error, the average value is 0.001 mm . It has little influence on calibration, generally no more than $2^{\prime \prime}$. So $\delta_{2}=2^{\prime \prime}$.

The error of the angle reference is the precision of the reference encoder, so $\delta_{3}=2^{\prime \prime}$.

The uncertainty of precision test is $\left(0.62^{2}+2^{2}+2^{2}\right)^{1 / / 2}=$ $2.9^{\prime \prime}$. The mean square error of our device is $21.14^{\prime \prime}$, so by analyzing, the uncertainty of the proposed device is $\left(0.62^{2}+\right.$ $\left.2^{2}+2^{2}+21.14^{2}\right)^{1 / 2}=21.34^{\prime \prime}$.

## VII. Conclusions

At present, the research of angular displacement measurement technology is developing towards smaller, higher precision and higher resolution. While miniaturizing angular displacement measurement, ensuring reliability is also a very important research content. In the future, miniaturization, high resolution and high reliability angular displacement measurement technology will be more mature and applied in various industries.

This paper proposed a high-resolution angular displacement method based on differences in moiré figure phase positions. We first built moiré figure model and corresponding phase arithmetic. We then established an angle measurement model based on varying moiré figure phase positions.
To validate the feasibility and effectiveness of our method, we designed a $\Phi 35-\mathrm{mm}$ diameter encoder. The measurement resolution in the test represents a significant advantage over traditional measurement techniques. These tests show that angular displacement method based on differences of moiré figure phase positions can achieve a high resolution measurement when the diameter of calibration grating is small. The results presented here may provide a theoretical and technological foundation for further research on small-size, high-resolution photographic rotary encoders.

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